


Search Notes 	Application/Control No. 10517075	Applicant(s)/Patent Under Reexamination HENCH, JOHN J.
	Examiner Gerald Gauthier	Art Unit 2614

SEARCHED			
Class	Subclass	Date	Examiner
370	276, 286, 287, 524	5/25/2009	GG
375	220, 222, 227, 232, 219	5/25/2009	GG
379	406.01	5/25/2009	GG
370	252, 286, 291, 292	12/14/2009	GG
375	222, 233, 260, 265, 285	12/14/2009	GG
379	406.1, 406.06, 406.12	12/14/2009	GG
600	443	12/14/2009	GG
370	276, 286	5/21/2010	GG
375	220	5/21/2010	GG

SEARCH NOTES		
Search Notes	Date	Examiner
EAST (US-PGPUB; USPAT; FPRS; EPO; JPO; DERWENT; IBM_TDB)	5/25/2009	GG
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	12/14/2009	GG
EAST (US-PGPUB; USPAT; USOCR; FPRS; EPO; JPO; DERWENT; IBM_TDB)	5/21/2010	GG
Inventor's Name Search	5/21/2010	GG

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner
370	276, 286	5/21/2010	GG
375	220	5/21/2010	GG
	Interference Search History (see attached)	5/21/2010	GG

	/Gerald Gauthier/ Primary Examiner.Art Unit 2614
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